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facsimile transmittance

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2/5/2002

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Pages:

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Re:

Response to January 28, 2002 Office

cc:

Action in US Patent Application

09/823,196

Dear Examiner Nguyen:

Please find enclosed a response to the January 28, 2002 Office Action in United States Patent Application:

Title:

Source Reagent Compositions for CVD Formation of Gate Dielectric Thin Films Using

Amide Precursors and Method of Using Same

Application No.: 09/823,196 Filing Date: March 30, 2001

The enclosed response includes:

Response - 2 sheets

Facsimile Transmittal Cover Sheet - 1 sheet

Please call 203-794-1100 ext. 4184 if there are any problems with this transmittal.

Maggie Chappuis

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ATMI Docket: ATMI-510

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re United S	tates Patent Application of:	
Applicants:	Baum, Thomas H., et al.))
Serial No.:	09/823,196) Group Art Unit: 2811
Date Filed:	March 30, 2001) Examiner: Chuong Quang Nguyen
Title: Sour	ce Reagent Compositions for CVD	,)
Formation of	of Gate Dielectric Thin Films Using)
Amide Precursors and Method of Using Same)

FACSIMILE TRANSMISSION CERTIFICATE

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Maggie Chappuis

November 5, 2000

Date of Transmission

703-308-7722 Facsimile Number

RESPONSE TO OFFICE ACTION DATED JANUARY 28, 2002 IN U.S. PATENT APPLICATION 09/823,196

Assistant Commissioner for Patents Washington, DC 20231

Sir:

In response to the Office Action dated January 28, 2002, wherein a Restriction Requirement was imposed against the following claim groups:

- 1. Claims 79-85, drawn to a semiconductor device, classified in class 257, subclass 506; and
- 11. Claims 1-78, drawn to a method of making a semiconductor device, classified in class 438, subclass 100;

Patent Application 2771-510

Applicant provisionally elects Group II with traverse. Traversal of the restriction requirement is based on

the fact that 35 U.S.C. § 121 permits restriction only if two or more inventions are claimed in one

application, which are both independent and distinct.

In the January 28, 2002 Office Action, the statement of reasoning in support of restriction requirement

discusses distinctiveness in detail, but appears to presume that the Group I and Group II claims represent

independent inventions.

In fact, the metal silicate dielectric thin films of Group I are produced by the metalloamide and

aminosilane precursors of Group II. There is accordingly no basis for the claims of Group I and II to be

characterized as independent of one another.

It therefore is requested that the Examiner reconsider the propriety of the restriction requirement, and

withdraw same in favor of the continued consolidation and unitary prosecution of all claims 1-85 in the

present invention.

In view of the foregoing Applicant respectfully requests the restriction requirement be withdrawn upon

reconsideration.

Applicant does not believe that any fee is due in connection with the foregoing. However, any

deficiencies may be charged to deposit account 50-0860 in the name of Advanced Technology Materials,

Inc. In the event further questions should arise, the Examiner is invited to contact the undersigned at the

telephone number given below.

Date: February 5, 2002

Respectfully submitted,

Javoracit Chappino

Margaret Chappuis

Registration No. 45,735

Agent for Applicants

ADVANCED TECHNOLOGY MATERIALS, INC.

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Attorney Docket: 510

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